

400V Depletion-Mode Power MOSFET

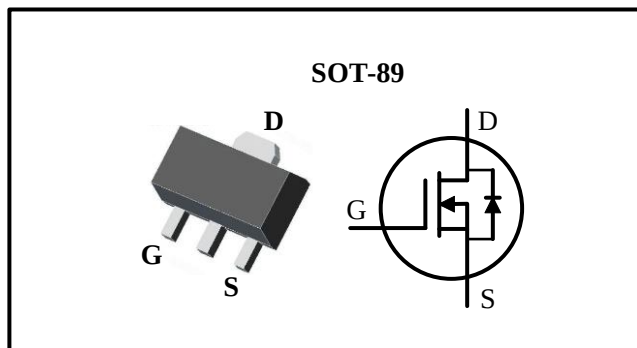
General Features

- Depletion Mode (Normally-on)
- Fast Switching Speed
- High Breakdown Voltage: 400V
- Small Package Size: SOT-89
- RoHS Compliant
- Halogen-free Available

BV_{DSX}	$R_{DS(ON)(Max.)}$	$I_{DSS(Min.)}$
400V	25Ω	200mA

Applications

- Solid State Relays
- Converters
- Linear Amplifiers
- Constant Current Sources
- Power Supply Circuits
- Telecom



Ordering Information

Part Number	Package	Marking	Remark
DMX22C40A	SOT-89	22C40	Halogen Free

Absolute Maximum Ratings

$T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	DMX22C40A	Unit
V_{DSX}	Drain-to-Source Voltage ^[1]	400	V
I_D	Continuous Drain Current	0.12	A
I_{DM}	Pulsed Drain Current ^[2]	0.48	
P_D	Power Dissipation	1	W
V_{GS}	Gate-to-Source Voltage	±20	V
T_L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	$^{\circ}\text{C}$
T_J & T_{STG}	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Note: The MOSFET is sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Thermal Characteristics

Symbol	Parameter	DMX22C40A	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	125	$^{\circ}\text{C/W}$

Electrical Characteristics

OFF Characteristics

 $T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
BV_{DSX}	Drain-to-Source Breakdown Voltage	400	--	--	V	$V_{GS}=-10\text{V}$, $I_D=250\mu\text{A}$
$I_{D(OFF)}$	Drain-to-Source Leakage Current	--	--	1	μA	$V_{DS}=400\text{V}$, $V_{GS}=-10\text{V}$
I_{GSS}	Gate-to-Source Leakage Current	--	--	1	μA	$V_{GS}=20\text{V}$, $V_{DS}=0\text{V}$
		--	--	-1		$V_{GS}=-20\text{V}$, $V_{DS}=0\text{V}$

ON Characteristics

 $T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I_{DSS}	Saturated Drain-to-Source Current	200	--	--	mA	$V_{GS}=0\text{V}$, $V_{DS}=25\text{V}$
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance	--	12	25	Ω	$V_{GS}=0\text{V}$, $I_D=100\text{mA}$ [3]
$V_{GS(OFF)}$	Gate-to-Source Cut-off Voltage	-4.5	--	-2.0	V	$V_{DS}=3\text{V}$, $I_D=8\mu\text{A}$
gfs	Forward Transconductance	--	300	--	mS	$V_{DS}=20\text{V}$, $I_D=100\text{mA}$

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
C_{iss}	Input Capacitance	--	84	--	pF	$V_{GS}=-10\text{V}$ $V_{DS}=25\text{V}$ $f=1.0\text{MHz}$
C_{oss}	Output Capacitance	--	15.1	--		
C_{rss}	Reverse Transfer Capacitance	--	3.4	--		
Q_g	Total Gate Charge	--	3.7	--	nC	$V_{GS}=-10\text{V}\sim 10\text{V}$ $V_{DS}=150\text{V}$ $I_D=100\text{mA}$
Q_{gs}	Gate-to-Source Charge	--	0.9	--		
Q_{gd}	Gate-to-Drain (Miller) Charge	--	1.1	--		

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$t_{d(on)}$	Turn-on Delay Time	--	7.2	--	ns	$V_{GS}=-10\text{V}\sim 0\text{V}$ $V_{DD}=150\text{V}$ $I_D=100\text{mA}$ $R_G=10\Omega$
t_{rise}	Rise Time	--	4.8	--		
$t_{d(off)}$	Turn-off Delay Time	--	24.0	--		
t_{fall}	Fall Time	--	161	--		



Source-Drain Diode Characteristics

$T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
V_{SD}	Diode Forward Voltage	--	--	1.5	V	$I_{SD}=100\text{mA}$, $V_{GS}=-10\text{V}$

NOTE:

[1] $T_J=+25^{\circ}\text{C}$ to $+150^{\circ}\text{C}$.

[2] Repetitive rating, pulse width limited by maximum junction temperature.

[3] Pulse width $\leq 380\mu\text{s}$, duty cycle $\leq 2\%$.

Typical Characteristics

Figure 1. Maximum Power Dissipation vs. Case Temperature

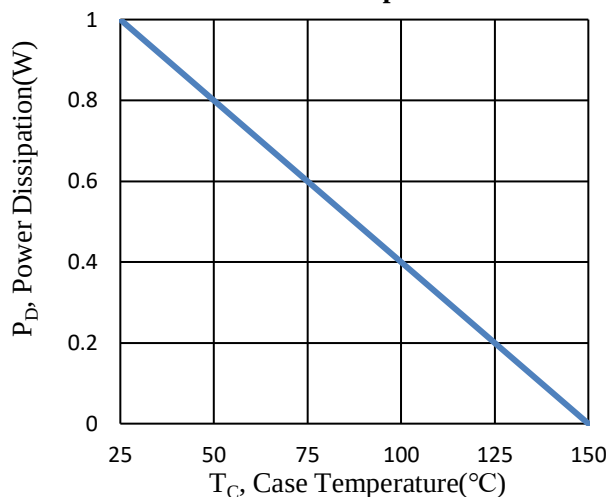


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

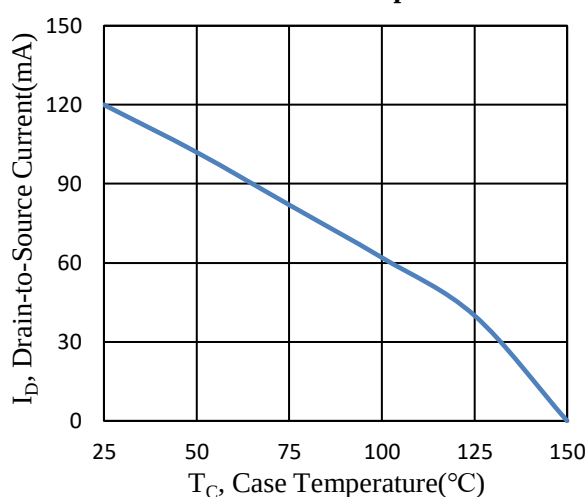


Figure 3. Typical Output Characteristics

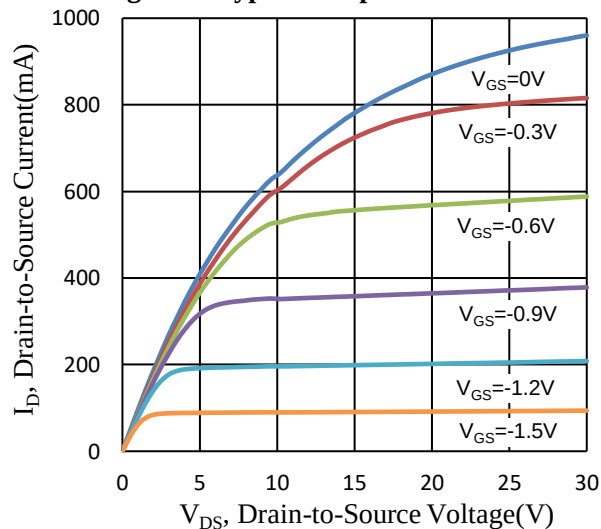


Figure 4. Typical Transfer Characteristics

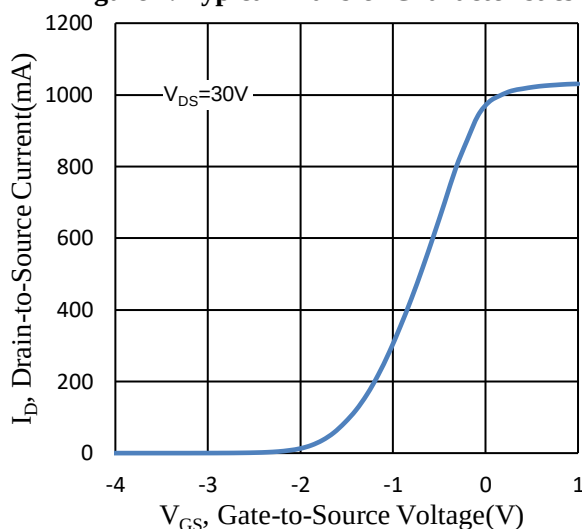


Figure 5. Typical Transfer Characteristics

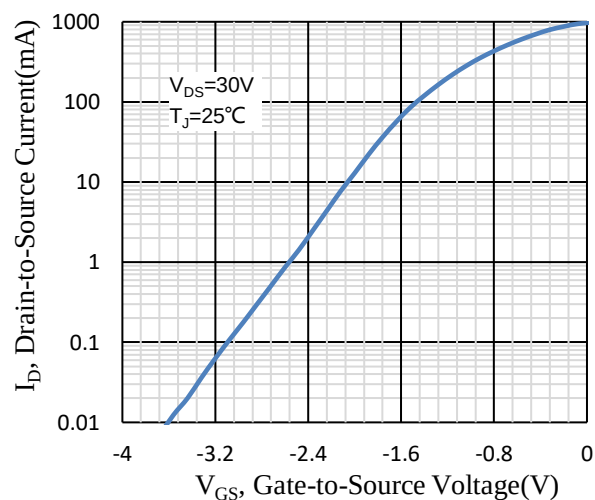


Figure 6. Typical Capacitance vs. Drain-to-Source Voltage

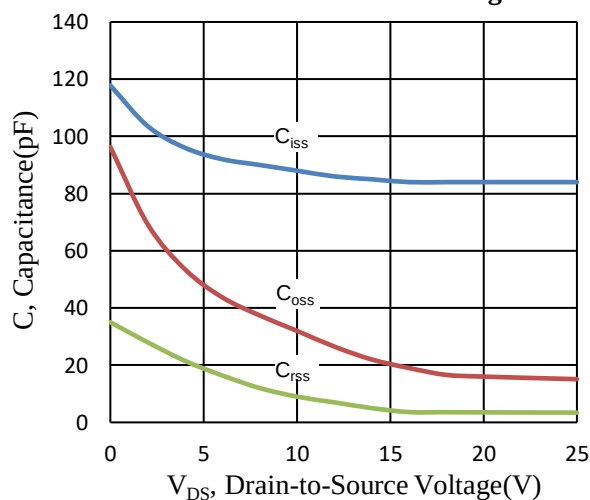
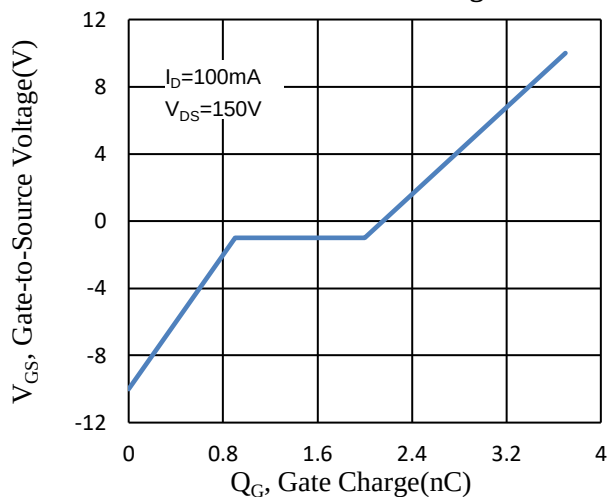
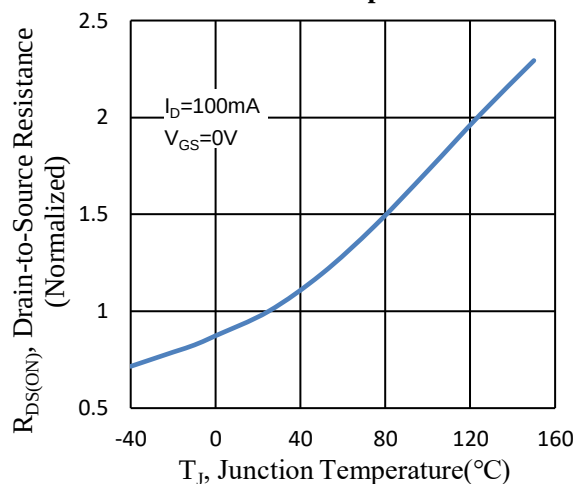
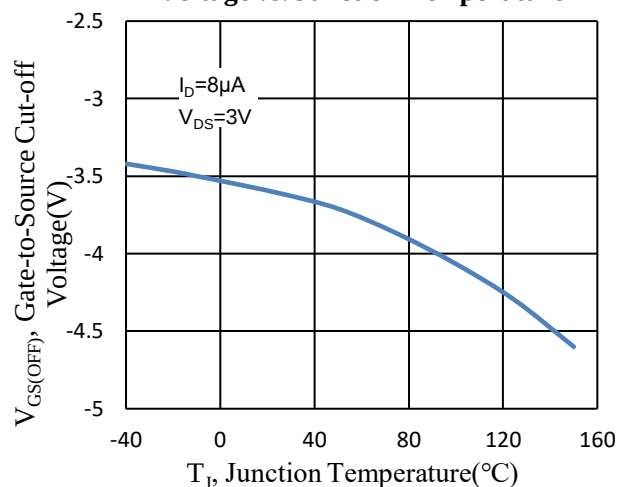
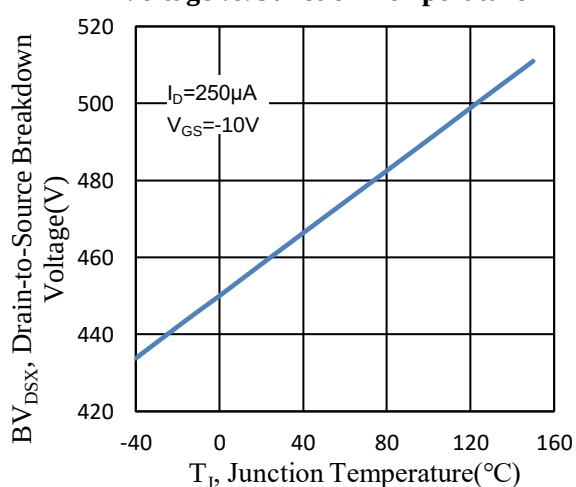
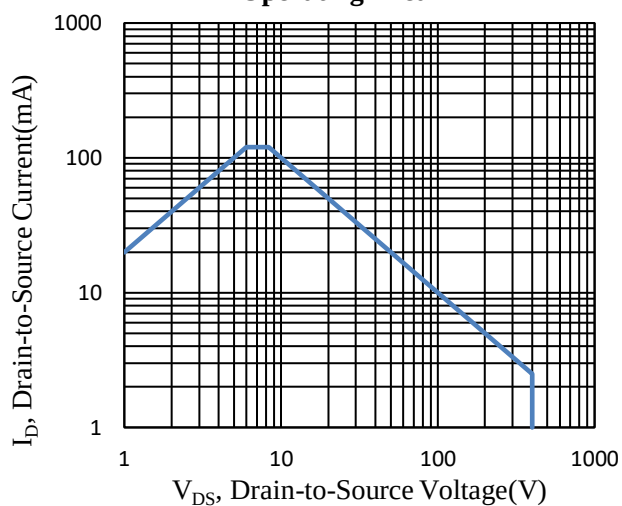
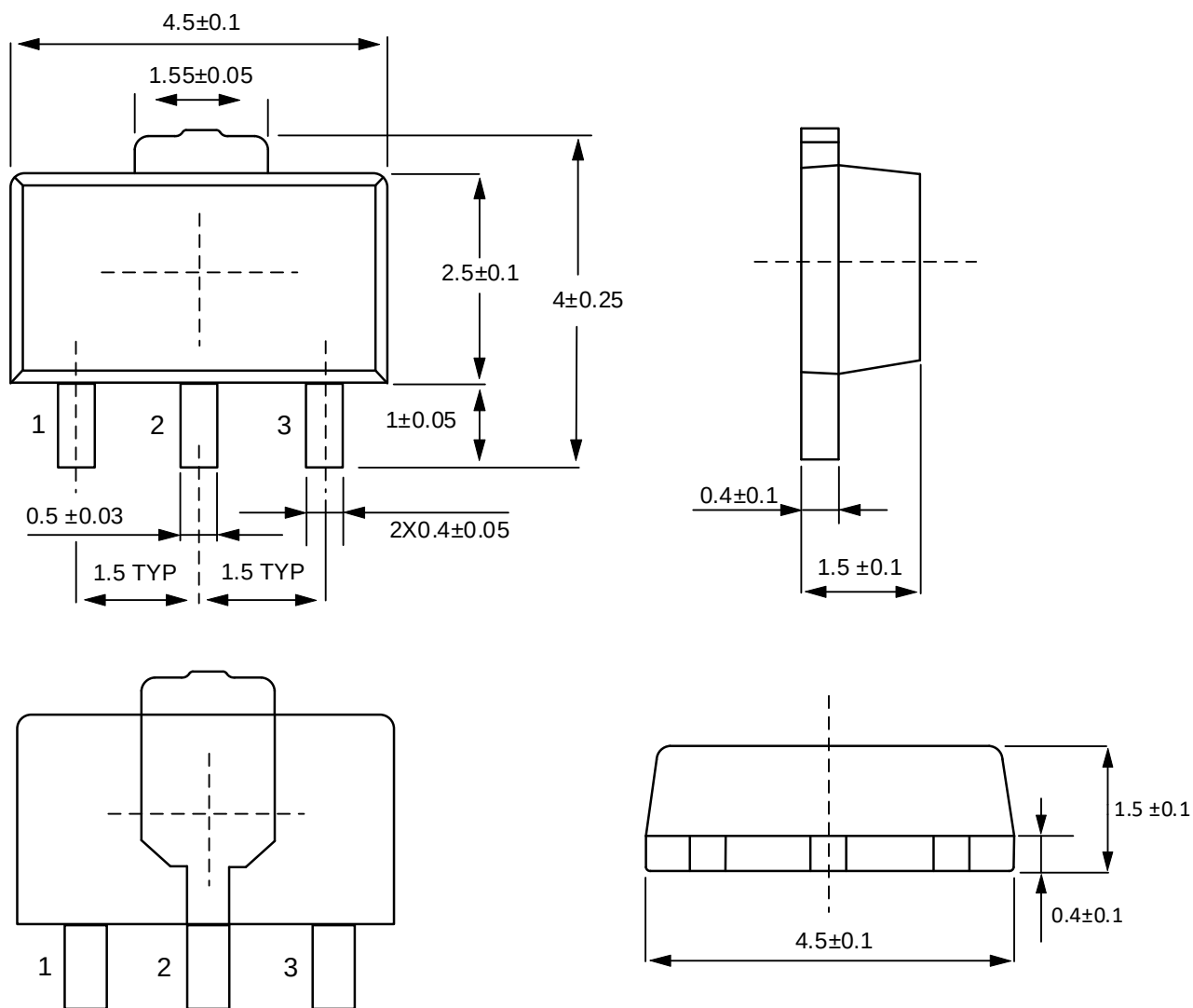


Figure 7. Typical Gate Charge vs. Gate-to-Source Voltage

Figure 8. Normalized On-Resistance vs. Junction Temperature

Figure 9. Gate-to-Source Cut-off Voltage vs. Junction Temperature

Figure 10. Drain-to-Source Breakdown Voltage vs. Junction Temperature

Figure 11. Maximum Forward Safe Operating Area


Package Dimensions

SOT-89





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